

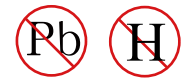


YEA SHIN TECHNOLOGY CO., LTD

YS4N65

N-Channel Enhancement MOSFET

V_{DS}= 650V, I_D= 4A



Feature

- R_{DS(ON)}<2.4Ω @ V_{GS}=10V
- Fast switching capability
- Lead free in compliance with EU RoHS directive.
- Green molding compound

Mechanical Data

- Case : TO-251, TO-252, TO-220, TO-220F, TO-262, TO-263

Ordering Information

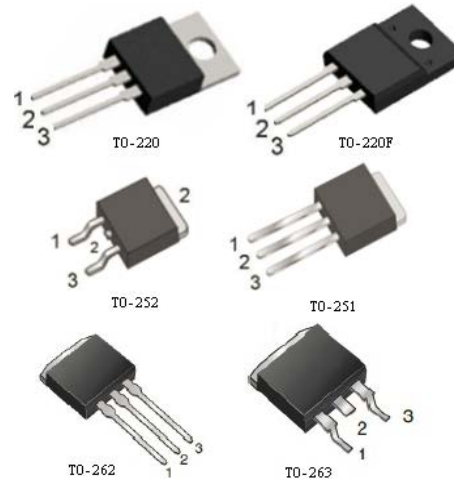
Part No.	Package	Packing
YS4N65R-TU	TO-251	75pcs / Tube
YS4N65D-TR	TO-252	2.5Kpcs / 13" Reel
YS4N65D-TU	TO-252	75pcs / Tube
YS4N65P-TU	TO-220	50pcs / Tube
YS4N65F-TU	TO-220F	50pcs / Tube
YS4N65J-TU	TO-262	50pcs / Tube
YS4N65H-TU	TO-263	50pcs / Tube
YS4N65H-TR	TO-263	800pcs / 13" Reel

PRODUCT SUMMARY

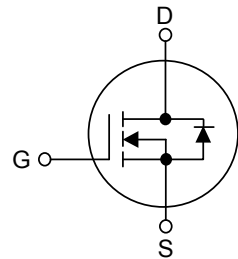
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)
650	2.4 @ V _{GS} =10V	4

Pin Definition:

1. Gate
2. Drain
3. Source



Block Diagram



ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	650	V
Gate-Source Voltage		V _{GSS}	±30	V
Continuous Drain Current		I _D	4	A
Pulsed Drain Current (Note 2)		I _{DM}	16	A
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	260	mJ
Power Dissipation	TO-251 / TO-252	P _D	50	W
	TO-220F		35	
	TO-220 / TO-262 / TO-263		106	
Junction Temperature		T _J	+150	°C
Operating Temperature		T _{OPR}	-55 ~ +150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature

3. L = 30mH, I_{AS} = 3.6A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C

DEVICE CHARACTERISTICS

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THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT
Junction to Ambient	TO-220 / TO-220F TO-262 / TO-263	θ_{JA}	62.5	°C/W
	TO-251/ TO-252		110	
Junction to Case	TO-220 / TO-220F TO-262 / TO-263	θ_{JC}	2.35	°C/W
	TO-220F		5.5	
	TO-251/ TO-252		2.9	

ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

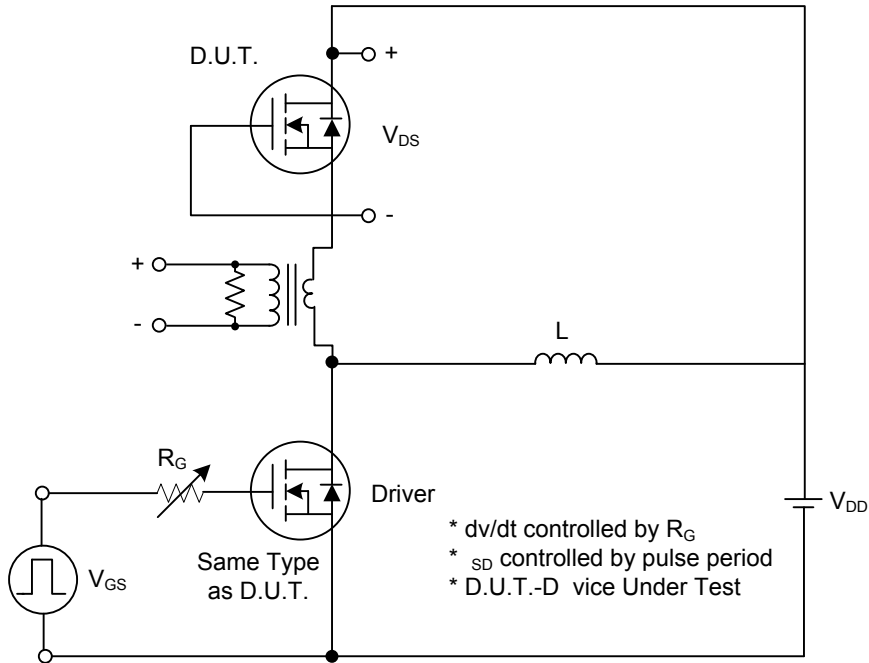
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} = 0V, I _D = 250μA	650			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} = 650V, V _{GS} = 0V			1	μA
Gate-Source Leakage Current	Forward	I _{GSS}	V _{GS} = 30V, V _{DS} = 0V			100	nA
	Reverse		V _{GS} = -30V, V _{DS} = 0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} = V _{GS} , I _D = 250μA	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} = 10 V, I _D = 2A		2.0	2.4	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{ISS}	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz		670		pF
Output Capacitance		C _{OSS}			70		pF
Reverse Transfer Capacitance		C _{RSS}			23		pF
SWITCHING CHARACTERISTICS							
Turn-On Delay Time		t _{D(ON)}	V _{DD} = 325V, I _D =4.0A, R _G = 25Ω (Note 1, 2)		45		ns
Turn-On Rise Time		t _R			100		ns
Turn-Off Delay Time		t _{D(OFF)}			200		ns
Turn-Off Fall Time		t _F			130		ns
Total Gate Charge		Q _G	V _{DS} = 520V,I _D = 4.0A, V _{GS} = 10V (Note 1, 2)		100		nC
Gate-Source Charge		Q _{GS}			17		nC
Gate-Drain Charge		Q _{GD}			20		nC
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS							
Drain-Source Diode Forward Voltage		V _{SD}	V _{GS} = 0V, I _S = 4A			1.4	V
Maximum Continuous Drain-Source Diode Forward Current		I _S				4	A
Maximum Pulsed Drain-Source Diode Forward Current		I _{SM}				16	A
Reverse Recovery Time		t _{rr}	V _{GS} = 0 V, I _S = 4A,		260		ns
Reverse Recovery Charge		Q _{RR}	dl _F /dt = 100 A/ μs (Note 1)		2.5		μC

Notes: 1. Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2%
2. Essentially independent of operating temperature

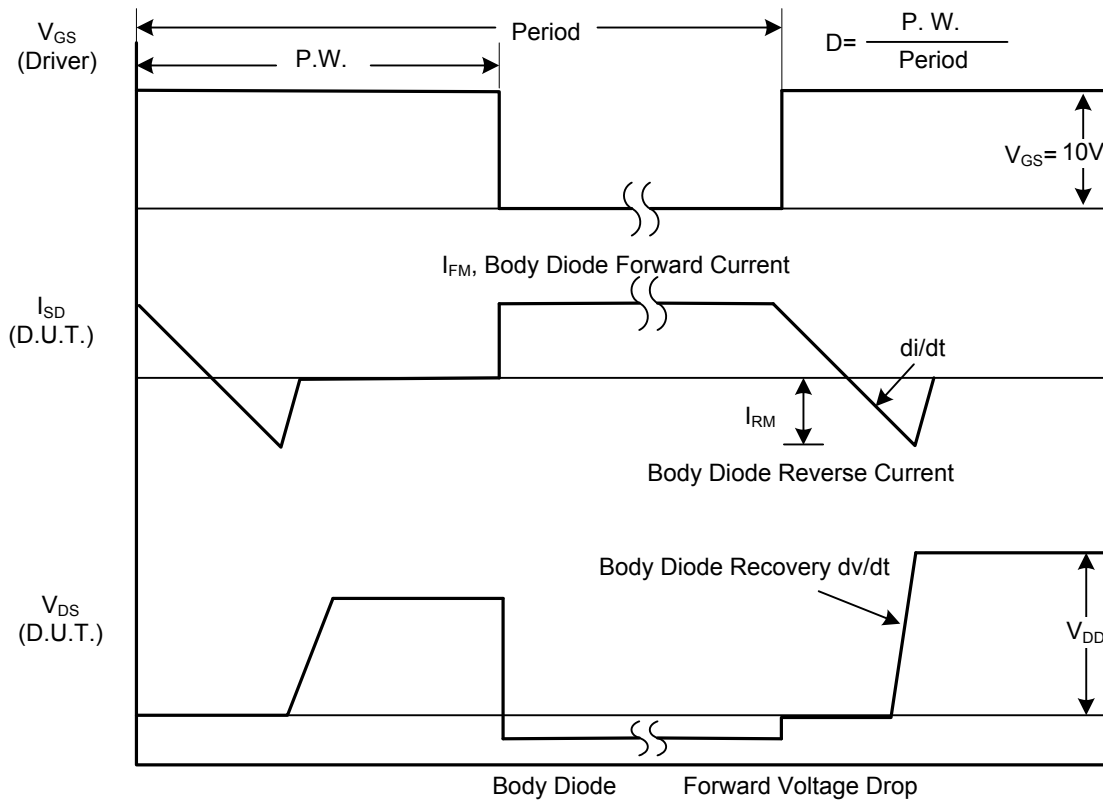
DEVICE CHARACTERISTICS

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TEST CIRCUITS AND WAVEFORMS



Peak Diode Recovery dv/dt Test Circuit

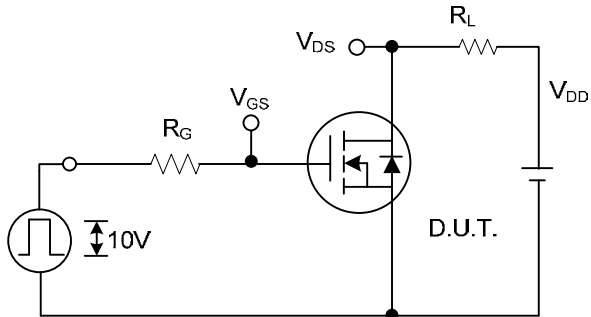


Peak Diode Recovery dv/dt Waveforms

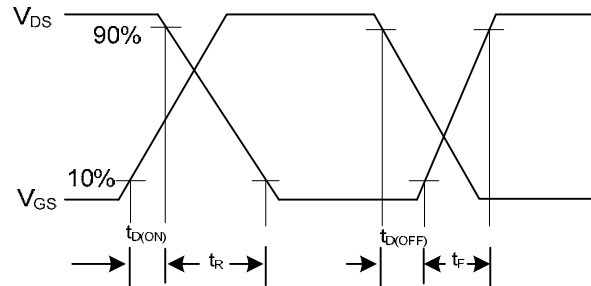
DEVICE CHARACTERISTICS

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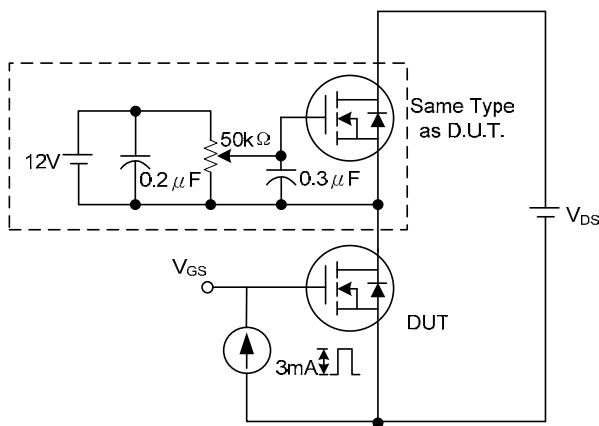
TEST CIRCUITS AND WAVEFORMS(Cont.)



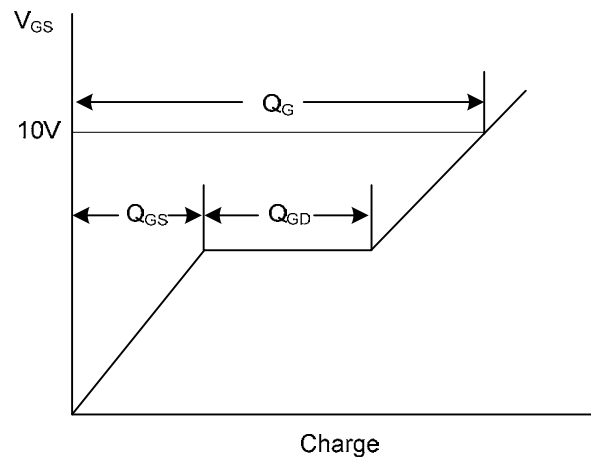
Switching Test Circuit



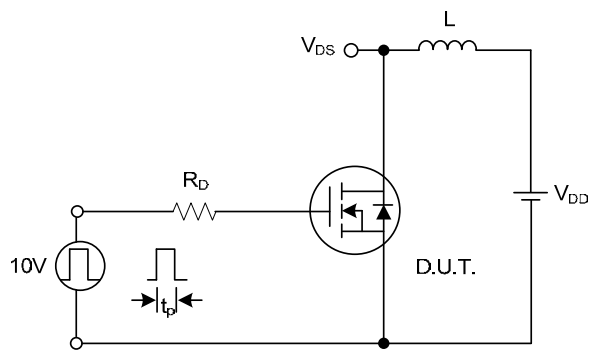
Switching Waveforms



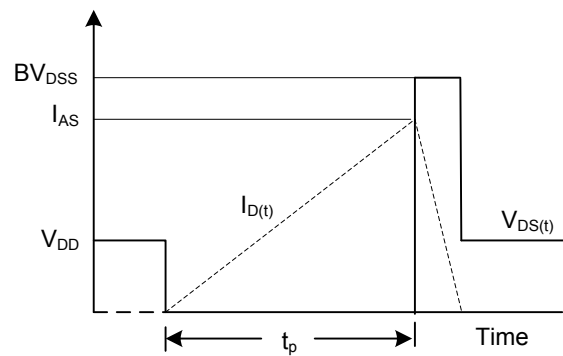
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit

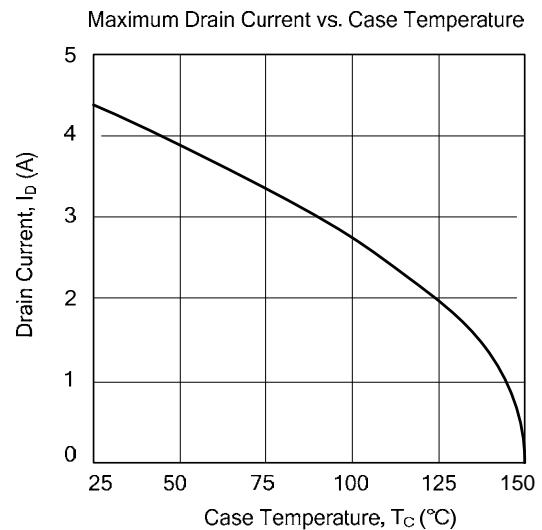
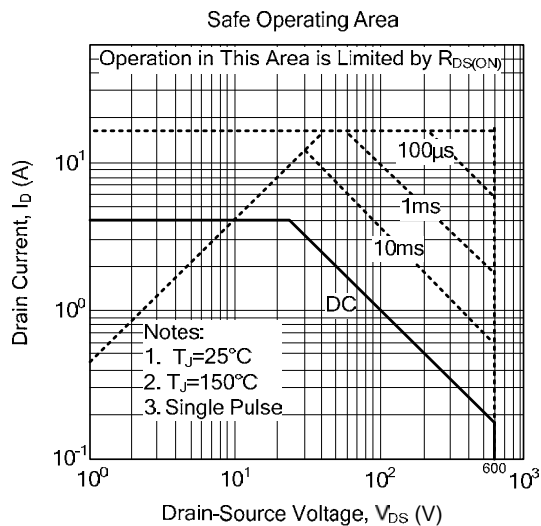
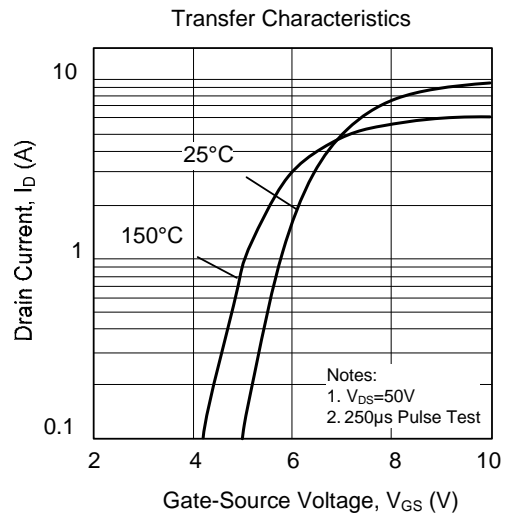
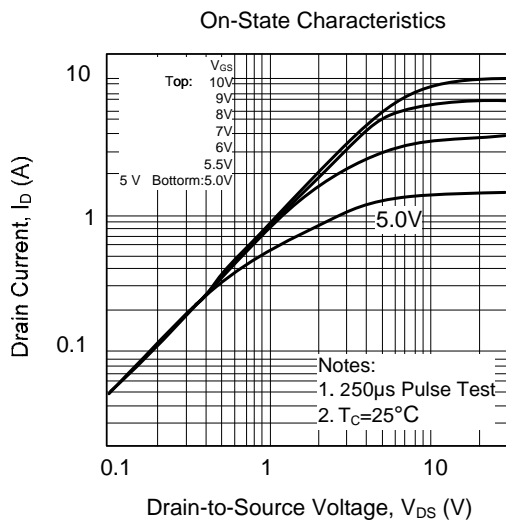
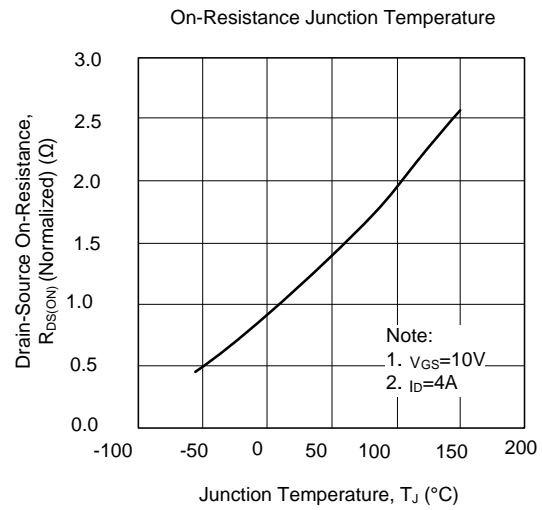
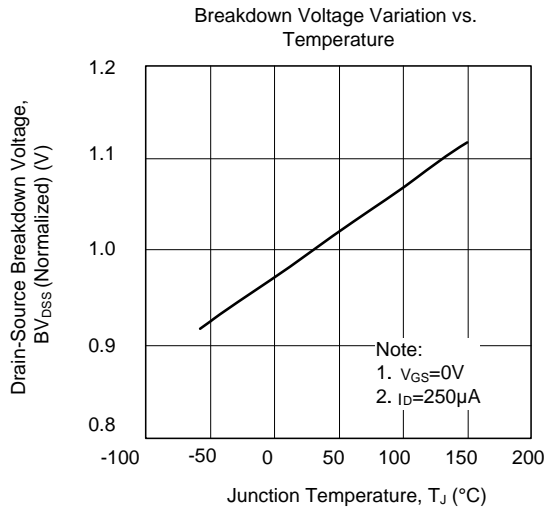


Unclamped Inductive Switching Waveforms

DEVICE CHARACTERISTICS

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TYPICAL CHARACTERISTICS

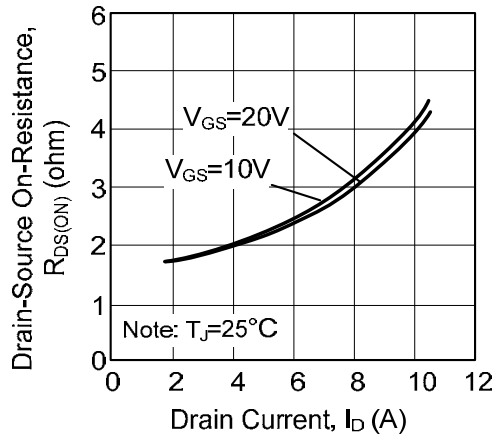


DEVICE CHARACTERISTICS

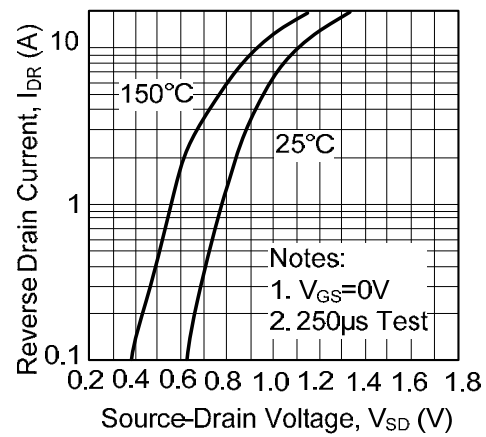
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TYPICAL CHARACTERISTICS

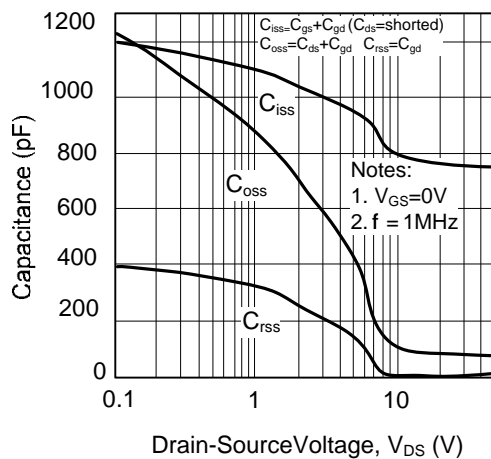
On-Resistance Variation vs. Drain Current and Gate Voltage



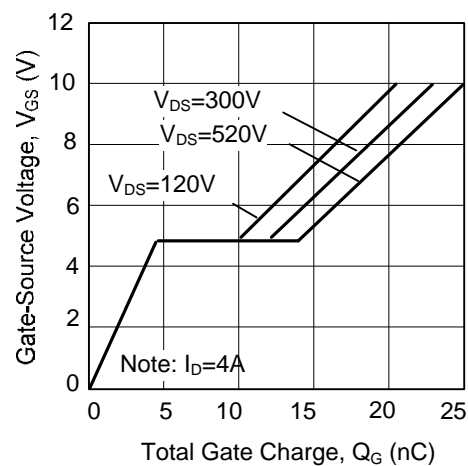
On State Current vs. Allowable Case Temperature



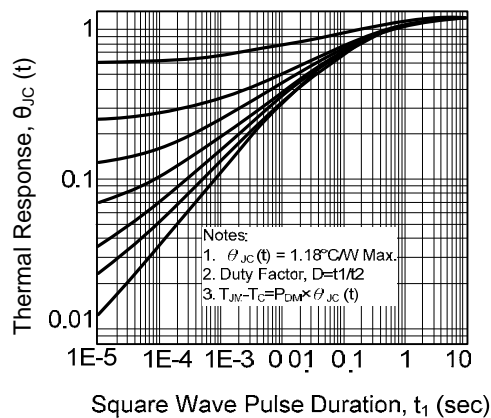
Capacitance Characteristics (Non-Repetitive)



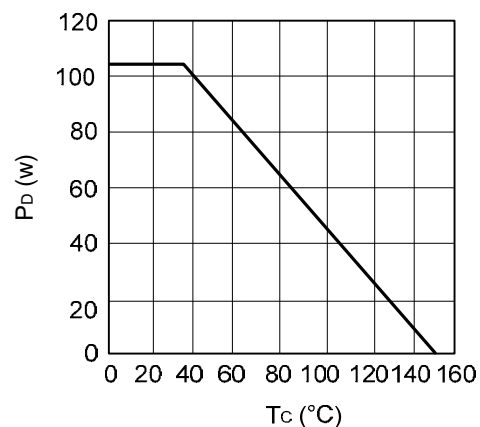
Gate Charge Characteristics



Transient Thermal Response Curve



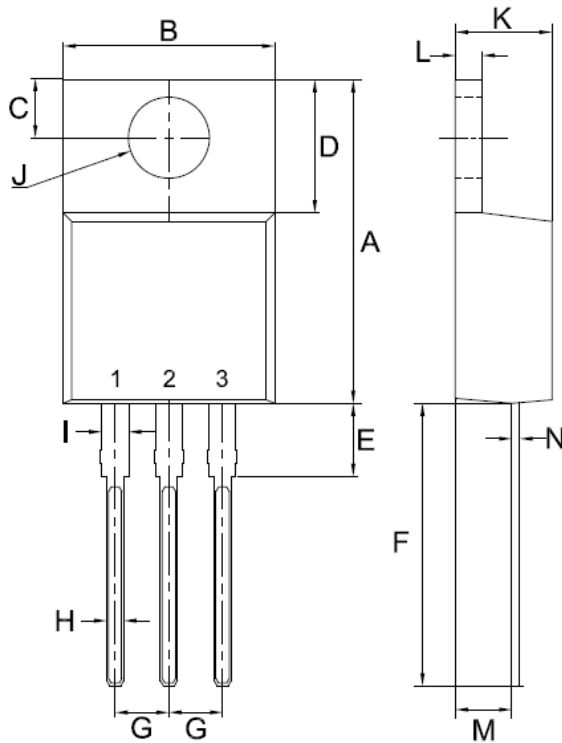
Power Dissipation



PACKAGE OUTLINE & DIMENSIONS

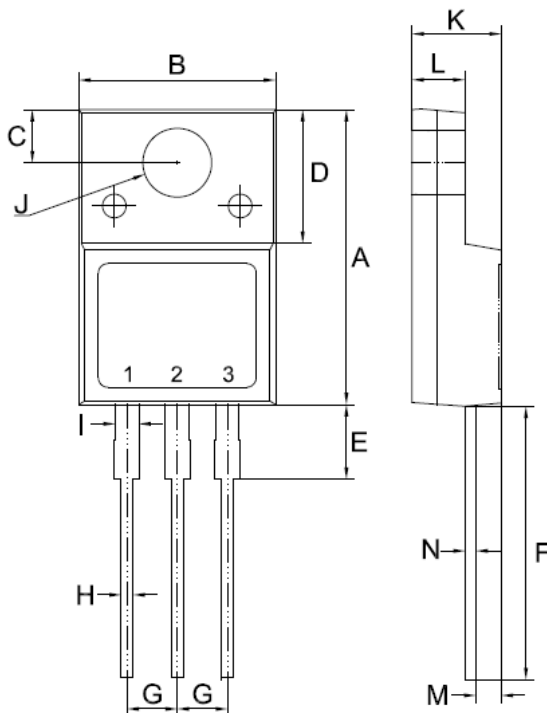
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TO-220 Mechanical Drawing



TO-220		
Unit:mm		
DIM	MIN	MAX
A	14.80	15.80
B	9.57	10.57
C	2.54	2.94
D	5.80	6.80
E	2.95	3.95
F	12.70	13.40
G	2.34	2.74
H	0.51	1.11
I	0.97	1.57
J	3.54 ϕ	4.14 ϕ
K	4.27	4.87
L	1.07	1.47
M	2.03	2.92
N	0.30	0.64

TO-220F Mechanical Drawing

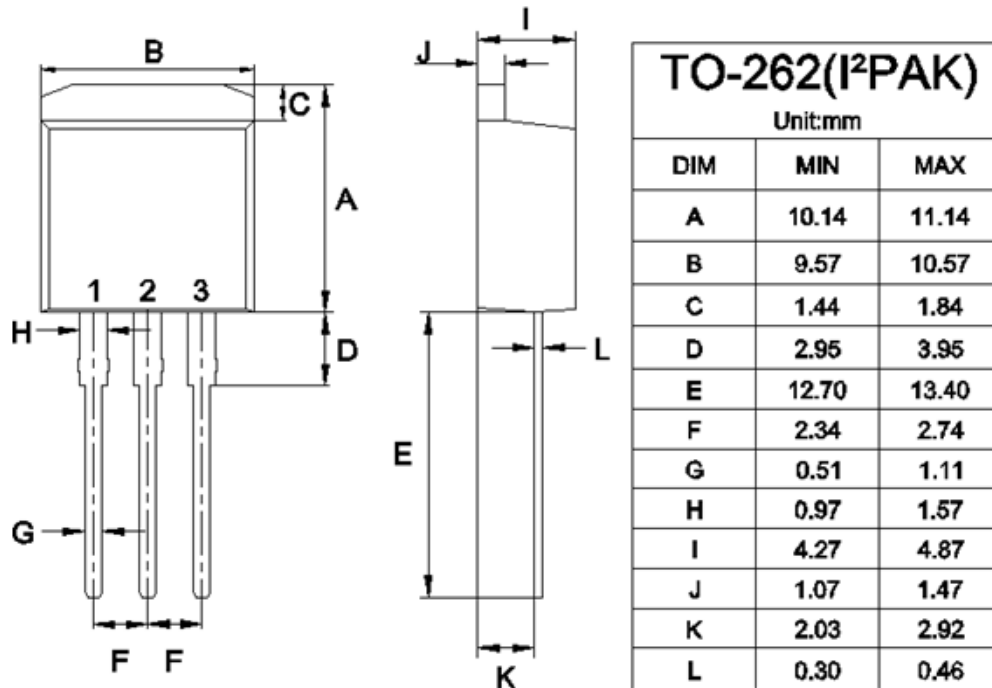


TO-220F		
Unit:mm		
DIM	MIN	MAX
A	14.50	15.50
B	9.50	10.50
C	2.50	2.90
D	6.30	7.30
E	3.30	4.30
F	13.00	14.00
G	2.35	2.75
H	0.30	0.90
I	0.90	1.50
J	3.20	3.80
K	4.24	4.84
L	2.52	2.92
M	1.09	1.49
N	0.47	0.64

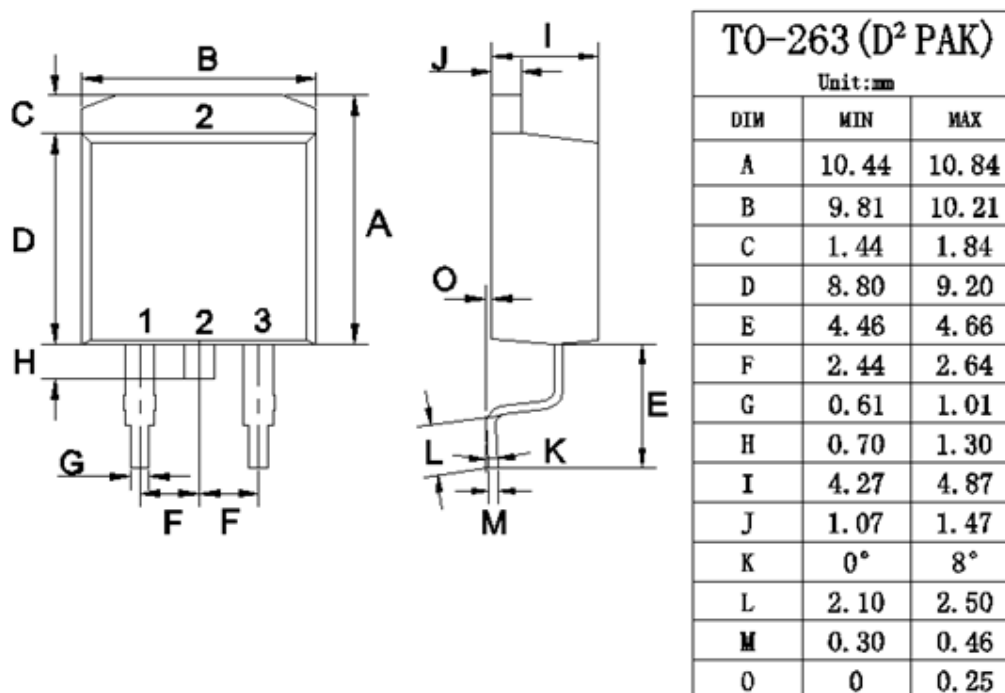
PACKAGE OUTLINE & DIMENSIONS

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TO-262 Mechanical Drawing



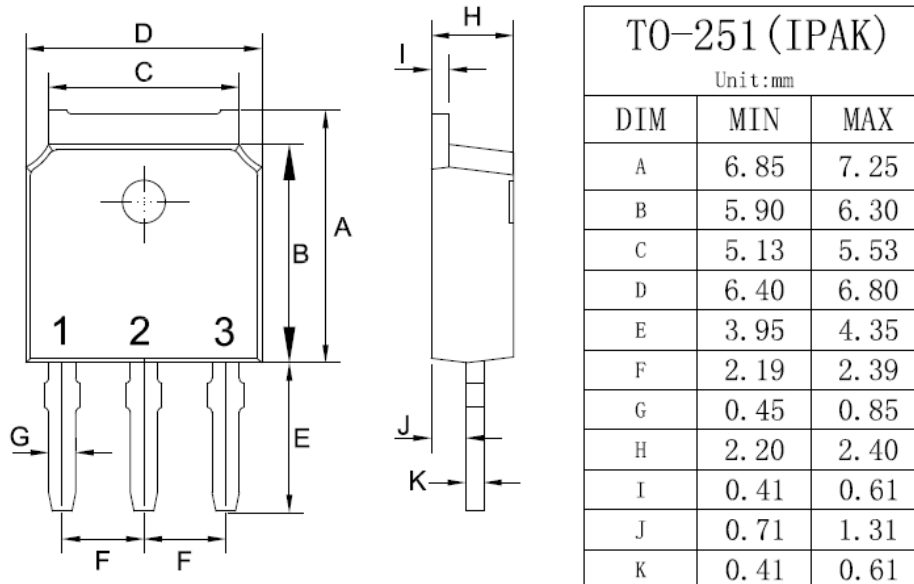
TO-263 Mechanical Drawing



PACKAGE OUTLINE & DIMENSIONS

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TO-251 Mechanical Drawing



TO-252 Mechanical Drawing

